REPORT No. : SZ16030124E01

FCC TEST REPORT

APPLICANT	:	ZTE Corporation
PRODUCT NAME	:	LTE Digital Mobile Handset
MODEL NAME	:	ZTE Blade A315
TRADE NAME	:	ZTE
BRAND NAME	:	ZTE
FCC ID	:	SRQ-A315
STANDARD(S)	:	47 CFR Part 15 Subpart B
TEST DATE	:	2016-03-25 to 2016-04-15
ISSUE DATE	:	2016-04-21

SHENZHEN MORLAB COMMUNICATIONS TECHNOLOGY Co., Ltd.

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Change History		
Issue	Date	Reason for change
1.0	2016-04-21	First edition

Test Report Declaration

Applicant	ZTE Corporation
Applicant Address	ZTE Plaza, Keji Road South, Hi-Tech, Industrial Park, Nanshan District, Shenzhen, Guangdong, P.R.China
Manufacturer	ZTE Corporation
Manufacturer Address	ZTE Plaza, Keji Road South, Hi-Tech, Industrial Park, Nanshan District, Shenzhen, Guangdong, P.R.China
Product Name	LTE Digital Mobile Handset
Model Name	ZTE Blade A315
Brand Name	ZTE
HW Version	A315_V1AMB_B
SW Version	A315_Z99_MX_9S8O21k800K101
Test Standards	47 CFR Part 15 Subpart B
Test Result	PASS

Tested by : Wang Da long

Wang Dalong (Test Engineer)

Reviewed by : Xiao Xiong

Xiao Xiong (EMC Manager)

Approved by : _____

Zeng Dexin (Chief Engineer)

1. Technical Information

Note: Provided by applicant

1.1. Applicant Information

Company: ZTE Corporation
Address: ZTE Plaza, Keji Road South, Hi-Tech, Industrial Park, Nanshan District, Shenzhen, Guangdong, P.R.China

1.2. Equipment under Test (EUT) Description

EUT Type:	LTE Digital Mobile Handset
Serial No:	(n.a., marked #1 by test site)
Hardware Version:	A315_V1AMB_B
Software Version:	A315_Z99_MX_9S8O21k800K101

Power supply:	**Battery**	
	Brand Name:	ZTE
	Model No.:	Li3822T43P4h746241
	Serial No.:	(n.a. marked #1 by test site)
	Capacity:	2200mAh
	Rated Voltage:	3.8V
	Charge Limit:	4.35V
Ancillary Equipment1:	**AC Adapter (Charger for Battery)**	
	Brand Name:	ZTE
	Model No.:	STC-A22O50I1000USBA-C
	Serial No.:	(n.a. marked #1 by test site)
	Rated Input:	~ 100-240V, 50/60Hz, 300mA
	Rated Output:	⎓ 5V, 1000mA

NOTE:

1. The EUT is a LTE Digital Mobile Handset, it supports GSM850MHz, GSM1900MHz, GPRS, EDGE, WCDMA Band Ⅱ, Band Ⅴ, HSDPA, HSUPA, HSPA+, FDD-LTE Band2/5/7/28, GPS, ISM 2.4GHz Bluetooth band and WIFI(802.11b/g/n) band.
2. It is equipped with a T-Flash card slot, a Micro-B USB port which can be connected to the

ancillary equipments. It supports FM function.

3. For a more detailed description, please refer to specification or user's manual supplied by the applicant and/or manufacturer.

2. Test Results

2.1. Applied Reference Documents

The objective of the report is to perform testing according to 47 CFR Part 15 Subpart B:

No.	Identity	Document Title
1	47 CFR Part 15(April 18, 2016 Edition)	Radio Frequency Devices

Test detailed items/section required by FCC rules and results are as below:

No.	Section	Description	Test Date	Result
1	15.107	Conducted Emission	2016.04.10	PASS
2	15.109	Radiated Emission	2016.04.10	PASS

NOTE: The tests were performed according to the method of measurements prescribed in ANSI C63.4-2014.

3. Test Conditions Setting

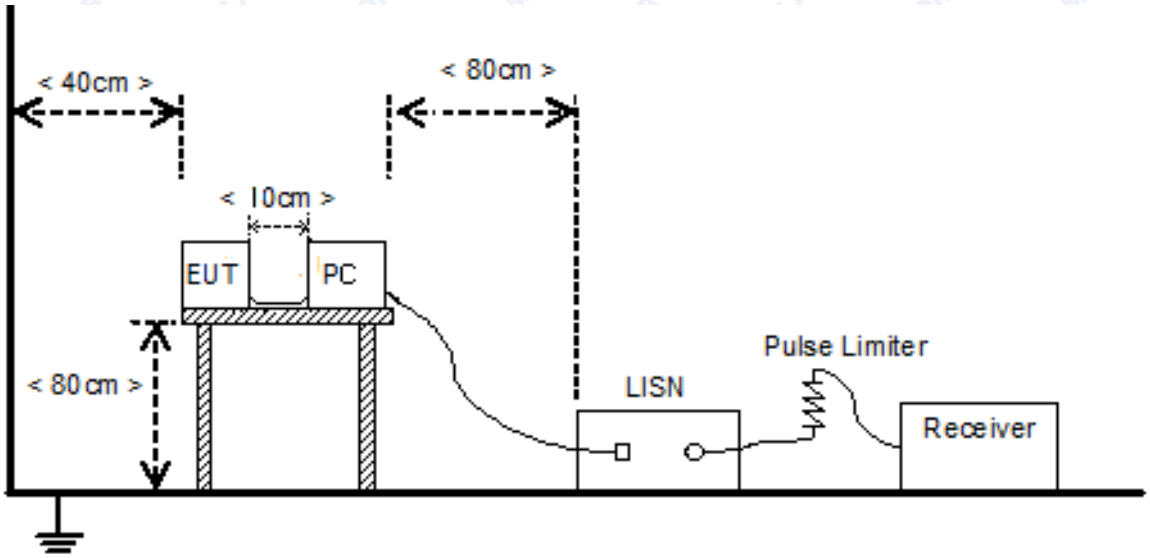
3.1. Test Mode

1	**The first test mode (Data Transmission)**
	The EUT configuration of the emission tests is EUT + Battery + T-Flash Card + PC. In this test mode, the EUT with a T-Flash Card embedded was connected to a PC via the Micro-B USB port. During the measurement, the data is transmitting between the PC and the T-Flash Card of the EUT.
2	**The second test mode (Standby)**
	The EUT configuration of the emission tests is EUT + Battery + Charger. During the measurement, the EUT was charged by its adapter and turned on.
Note: All test modes are performed, only the worse case (Data Transmission) is recorded in this report.	

3.2. Test Setup and Equipments List

3.2.1. Conducted Emission

A. Test Setup:



The EUT is placed on a 0.8m high insulating table, which stands on the grounded conducting floor, and keeps 0.4m away from the grounded conducting wall. The EUT is connected to the power mains through a LISN which provides 50Ω/50μH of coupling impedance for the measuring instrument. A Pulse Limiter is used to protect the measuring instrument. The factors of the whole test system are calibrated to correct the reading.

The power strip or extension cord has been investigated to make sure that the LISN integrity in maintained with respect to the impedance characteristics as prescribed in ANSI C63.4-2014 at Clause 4.3.

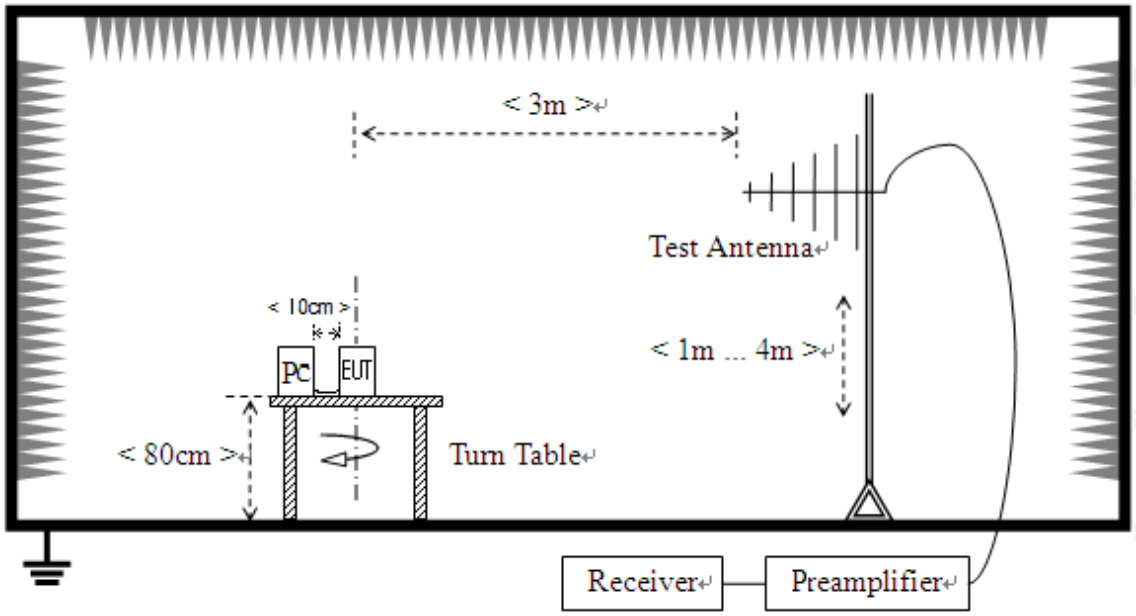
B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
Receiver	Narda	PMM 9010	595WX11007	2015.5.07	2016.5.06
LISN	Schwarzbeck	NSLK 8127	812744	2015.6.18	2016.6.17
Pulse Limiter (20dB)	VTSD	9561D	9537	2015.5.07	2016.5.06
PC	Apple	A1370	C02FQ2PYD DQW	(n.a.)	(n.a.)

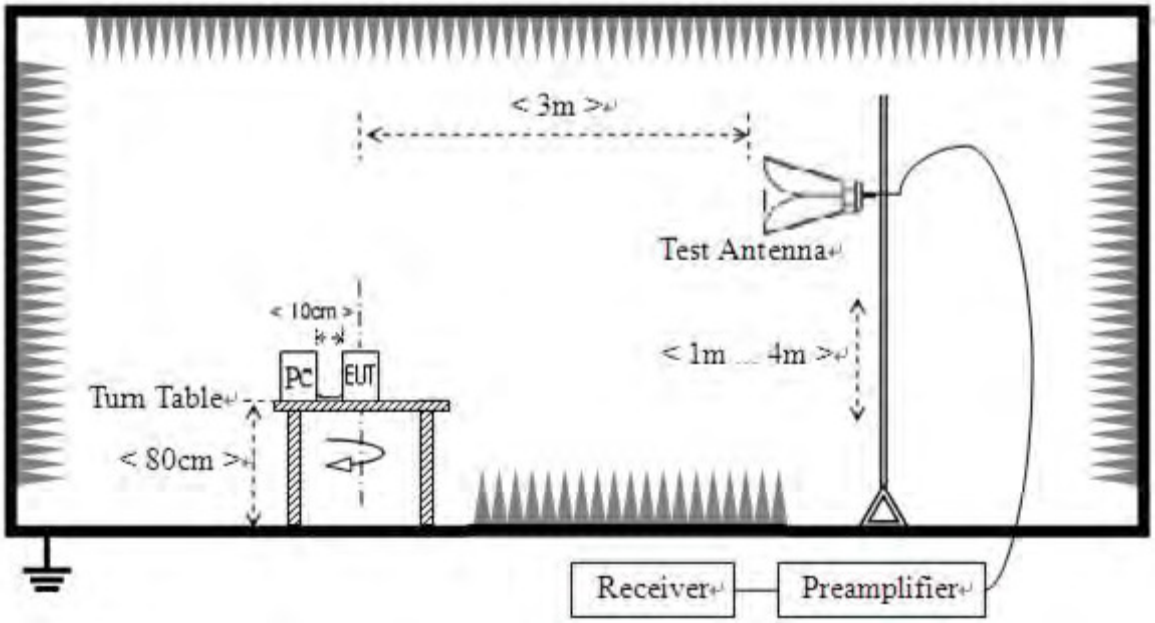
3.2.2. Radiated Emission

A. Test Setup:

1. For radiated emissions from 30MHz to1GHz



2. For radiated emissions above 1GHz



The test is performed in a 3m Semi-Anechoic Chamber; the antenna factor, cable loss and so on of the site (factors) is calculated to correct the reading. The EUT is placed on a 0.8m high insulating Turn Table, and keeps 3m away from the Test Antenna, which is mounted on a variable-height antenna master tower.

For the test Antenna:

In the frequency range above 30MHz, Bi-Log Test Antenna (30MHz to 1GHz) and Horn Test Antenna (above 1GHz) are used. Test Antenna is 3m away from the EUT. Test Antenna height is varied from 1m to 4m above the ground to determine the maximum value of the field strength. The emission levels at both horizontal and vertical polarizations should be tested.

B. Equipments List:

Description	Manufacturer	Model	Serial No.	Cal. Date	Due. Date
MXE EMI Receiver	Agilent	N9038A	MY54130016	2015.5.07	2016.5.06
Semi-Anechoic Chamber	Albatross	9m*6m*6m	(n.a.)	2015.5.14	2016.5.13
Test Antenna - Bi-Log	Schwarzbeck	VULB 9163	9163-274	2015.6.23	2016.6.22
Test Antenna - Horn	Schwarzbeck	BBHA9120 C	9120C-384	2016.1.13	2017.1.12
PC	Apple	A1370	C02FQ2PYD DQW	(n.a.)	(n.a.)

4. 47 CFR Part 15B Requirements

4.1. Conducted Emission

4.1.1. Requirement

According to FCC section 15.107, the radio frequency voltage that is conducted back onto the AC power line on any frequency within the band 150kHz to 30MHz shall not exceed the limits in the following table, as measured using a 50µH/50Ω line impedance stabilization network (LISN).

Frequency range (MHz)	Conducted Limit (dBµV)	
	Quasi-peak	Average
0.15 - 0.50	66 to 56	56 to 46
0.50 - 5	56	46
5 - 30	60	50

NOTE:

a) The limit subjects to the Class B digital device.

b) The lower limit shall apply at the band edges.

c) The limit decreases linearly with the logarithm of the frequency in the range 0.15 - 0.50MHz.

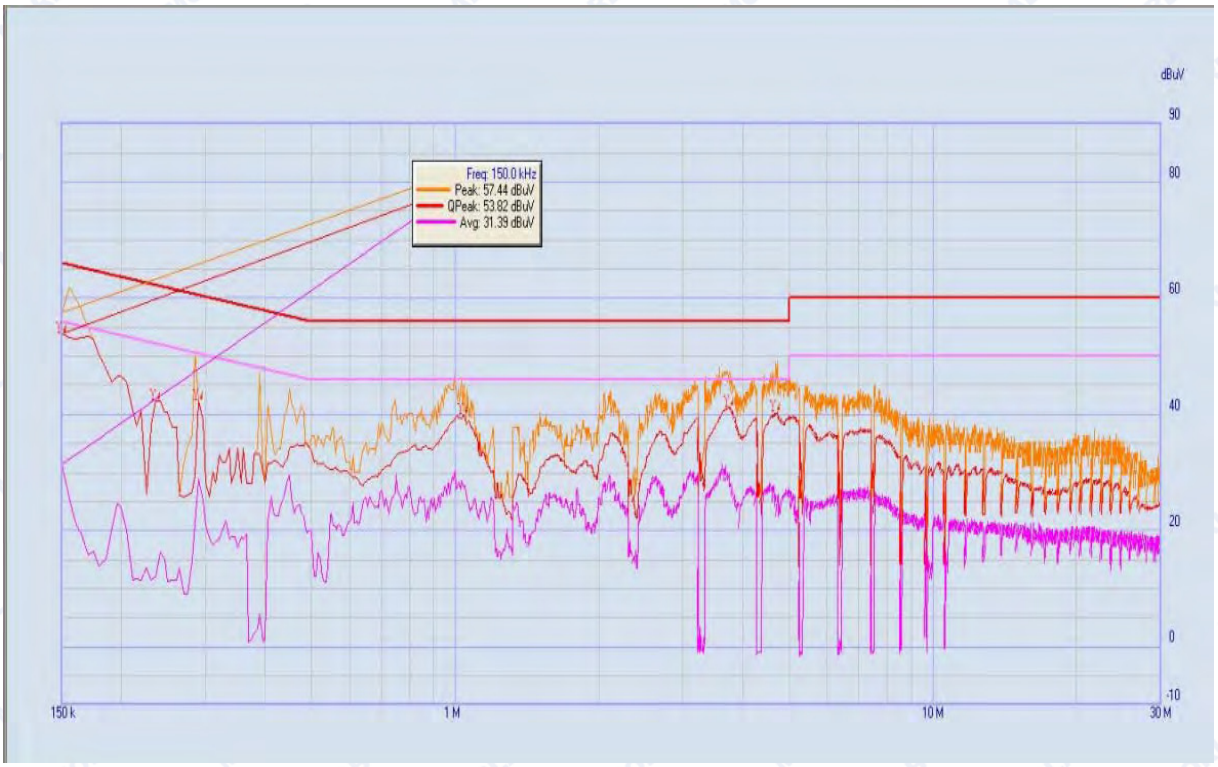
4.1.2. Test Description

See section 3.2.1 of this report.

4.1.3. Test Result

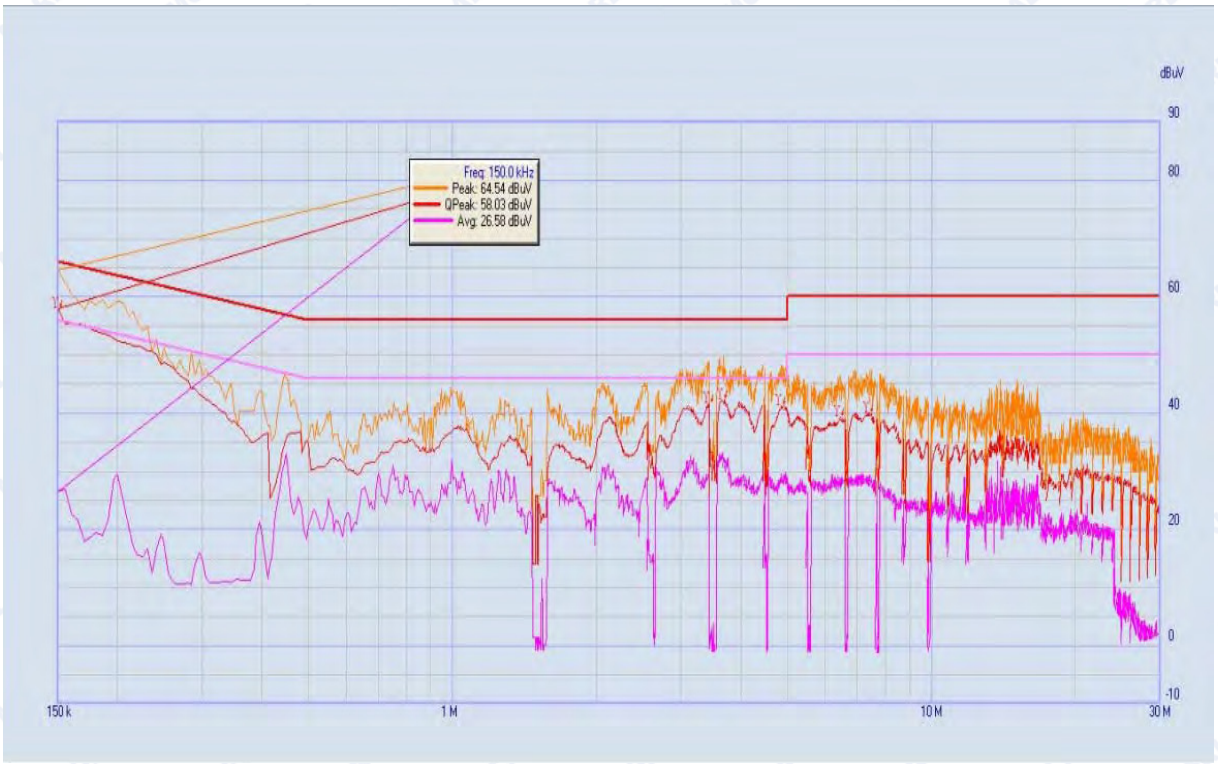
The maximum conducted interference is searched using Peak (PK), Quasi-peak (QP) and Average (AV) detectors; the emission levels more than the AV and QP limits, and that have narrow margins from the AV and QP limits will be re-measured with AV and QP detectors. Tests for both L phase and N phase lines of the power mains connected to the EUT are performed. All test modes are considered, refer to recorded points and plots below.

A. Test Plot and Suspicious Points:



(Plot A: L Phase)

No.	Fre. (MHz)	Emission Level (dBµV)		Limit (dBµV)		Power-line	Verdict
		Quai-peak	Average	Quai-peak	Average		
1	0.15	53.82	31.39	66.00	56.00	Line	PASS
2	0.235	42.35	12.13	63.57	53.57		PASS
3	0.29	42.26	28.74	62.00	52.00		PASS
4	1.04	39.68	27.48	56.00	46.00		PASS
5	3.73	41.30	29.73	56.00	46.00		PASS
6	4.69	40.36	25.20	56.00	46.00		PASS



(Plot B: N Phase)

No.	Fre. (MHz)	Emission Level (dBµV)		Limit (dBµV)		Power-line	Verdict
		Quai-peak	Average	Quai-peak	Average		
1	0.15	58.03	26.58	66.00	56.00	Neutral	PASS
2	3.43	41.60	30.12	56.00	46.00		PASS
3	3.665	42.10	30.76	56.00	46.00		PASS
4	4.855	41.18	28.46	56.00	46.00		PASS
5	6.41	39.00	27.98	60.00	50.00		PASS
6	7.41	39.73	28.03	60.00	50.00		PASS

Result: Pass

4.2. Radiated Emission

4.2.1. Requirement

According to FCC section 15.109 (a), the field strength of radiated emissions from unintentional radiators at a distance of 3 meters shall not exceed the following values:

Frequency range (MHz)	Field Strength Limitation at 3m Measurement Dist	
	(µV/m)	(dBµV/m)
30.0 - 88.0	100	20log 100
88.0 - 216.0	150	20log 150
216.0 - 960.0	200	20log 200
Above 960.0	500	20log 500

As shown in FCC section 15.35 (b), for frequencies above 1000MHz, the field strength limits are based on average detector. When average radiated emission measurements are specified in this part, including emission measurements below 1000MHz, there also is a limit on the radio frequency emissions, as measured using instrumentation with a peak detector function, corresponding to 20dB above the maximum permitted average limit for the frequency being investigated unless a different peak emission limit is otherwise specified in the rules.

Note:

1) The tighter limit shall apply at the boundary between two frequency range.
2) Limitation expressed in dBµV/m is calculated by 20log Emission Level (µV/m).
3) If measurement is made at 3m distance, then F.S Limitation at 3m distance is adjusted by using the formula of $Ld1 = Ld2 * (d2/d1)^{2.}$
   Example:
   F.S Limit at 30m distance is 30µV/m, then F.S Limitation at 3m distance is adjusted as
   $Ld1 = L1 = 30\mu V/m * (10)^2 = 100 * 30\mu V/m$

4.2.2. Test Description

See section 3.2.2 of this report.

4.2.3. Frequency range of measurement

According to 15.33(b) (1), the frequency range of radiated measurement for the EUT is listed in the following table:

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 1.705	30.
1.705–108	1000.
108–500	2000.
500–1000	5000.
Above 1000	5th harmonic of the highest frequency or 40 GHz, whichever is lower.

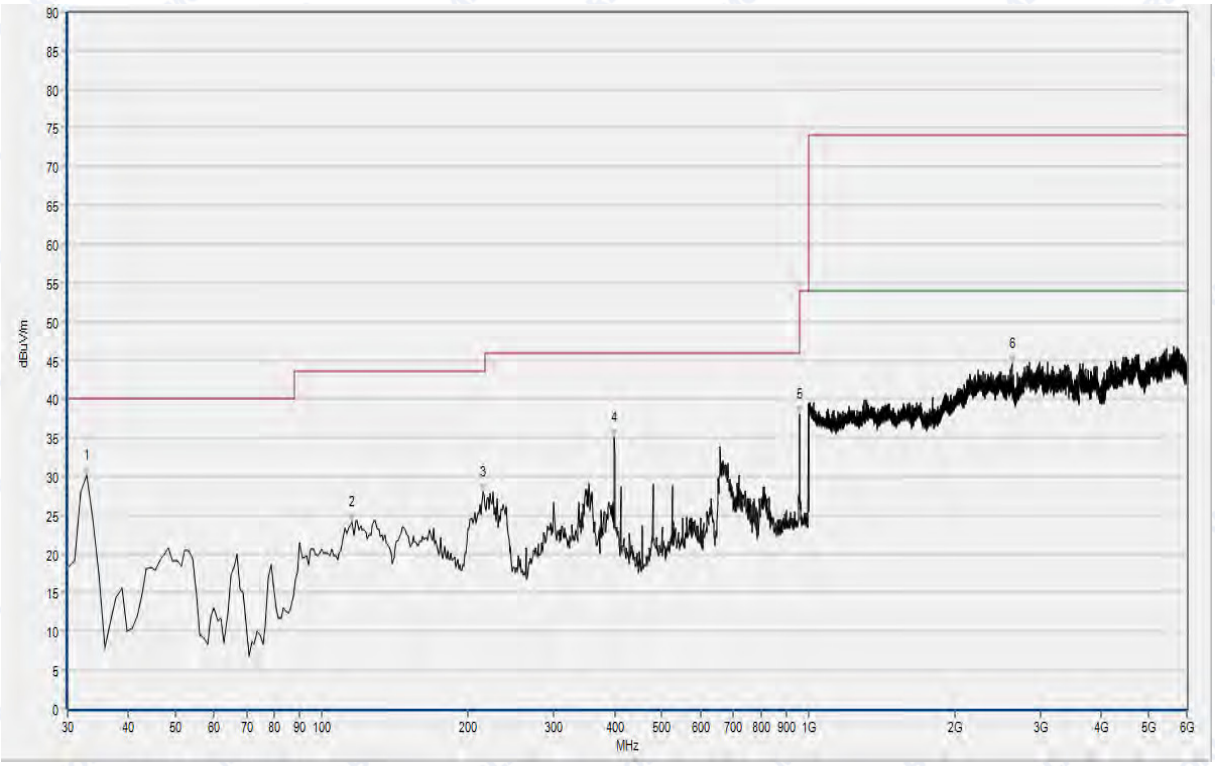
4.2.4. Test Result

The maximum radiated emission is searched using PK, QP and AV detectors; the emission levels more than the limits, and that have narrow margins from the limits will be re-measured with AV and QP detectors. Both the vertical and the horizontal polarizations of the Test Antenna are considered to perform the tests. All test modes are considered, refer to recorded points and plots below.

The amplitude of spurious emissions which are attenuated more than 20 dB below the permissible value need not be reported.

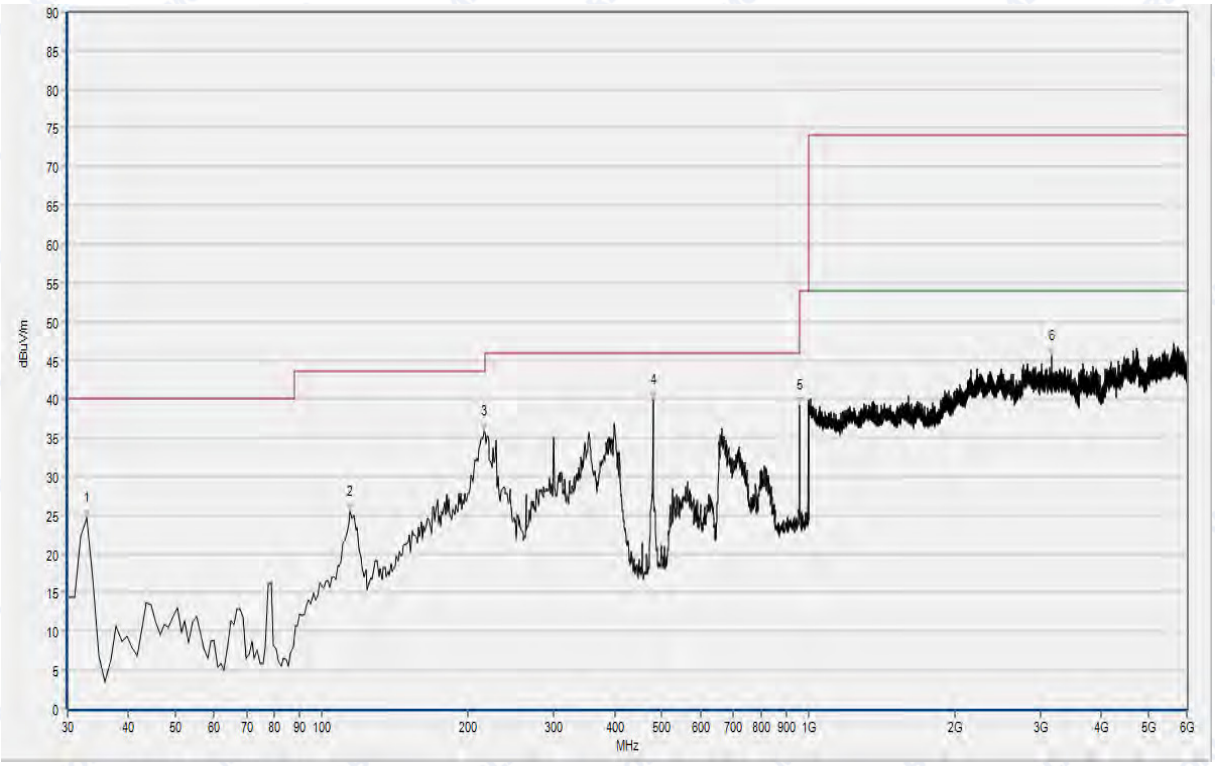
Note: All radiated emission tests were performed in X, Y, Z axis direction, and only the worst axis test condition was recorded in this test report.

A. Test Plots and Suspicious Points:



(Plot A: 30MHz – 6GHz, Test Antenna Vertical)

No.	Fre. MHz	Pk dBµV/m	QP dBµV/m	AV dBµV/m	Limit-PK dBµV/m	Limit-QP dBµV/m	Limit-AV dBµV/m	ANT	Verdict
1	32.910	N.A.	30.19	N.A.	N.A.	40.00	N.A.	V	PASS
2	115.360	N.A.	24.08	N.A.	N.A.	43.50	N.A.	V	PASS
3	214.300	N.A.	27.97	N.A.	N.A.	43.50	N.A.	V	PASS
4	399.570	N.A.	35.11	N.A.	N.A.	46.00	N.A.	V	PASS
5	960.230	N.A.	38.04	N.A.	N.A.	54.00	N.A.	V	PASS
6	2621.760	44.50	N.A.	38.64	74.00	N.A.	54.00	V	PASS



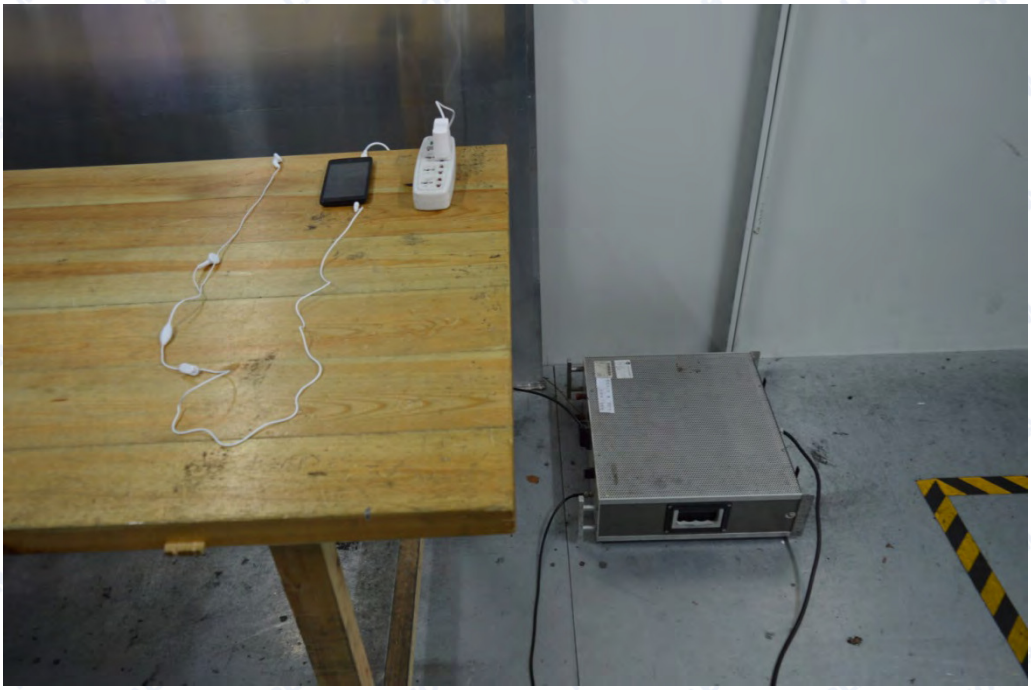
(Plot B: 30MHz – 6GHz, Test Antenna Horizontal)

No.	Fre. MHz	Pk dBμV/m	QP dBμV/m	AV dBμV/m	Limit-PK dBμV/m	Limit-QP dBμV/m	Limit-AV dBμV/m	ANT	Verdict
1	32.910	N.A	24.60	N.A	N.A	40.00	N.A	H	PASS
2	114.390	N.A	25.53	N.A	N.A	43.50	N.A	H	PASS
3	215.270	N.A	35.94	N.A	N.A	43.50	N.A	H	PASS
4	480.080	N.A	39.90	N.A	N.A	46.00	N.A	H	PASS
5	960.230	N.A	39.27	N.A	N.A	54.00	N.A	H	PASS
6	3160.640	45.60	N.A	39.02	74.00	N.A	54.00	H	PASS

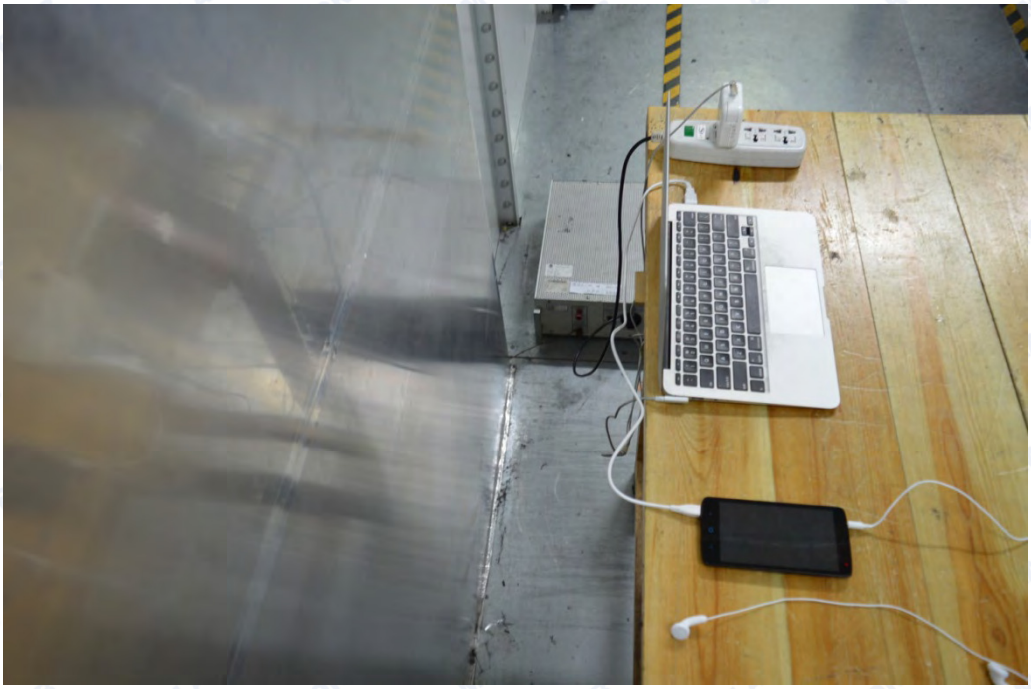
Result: Pass

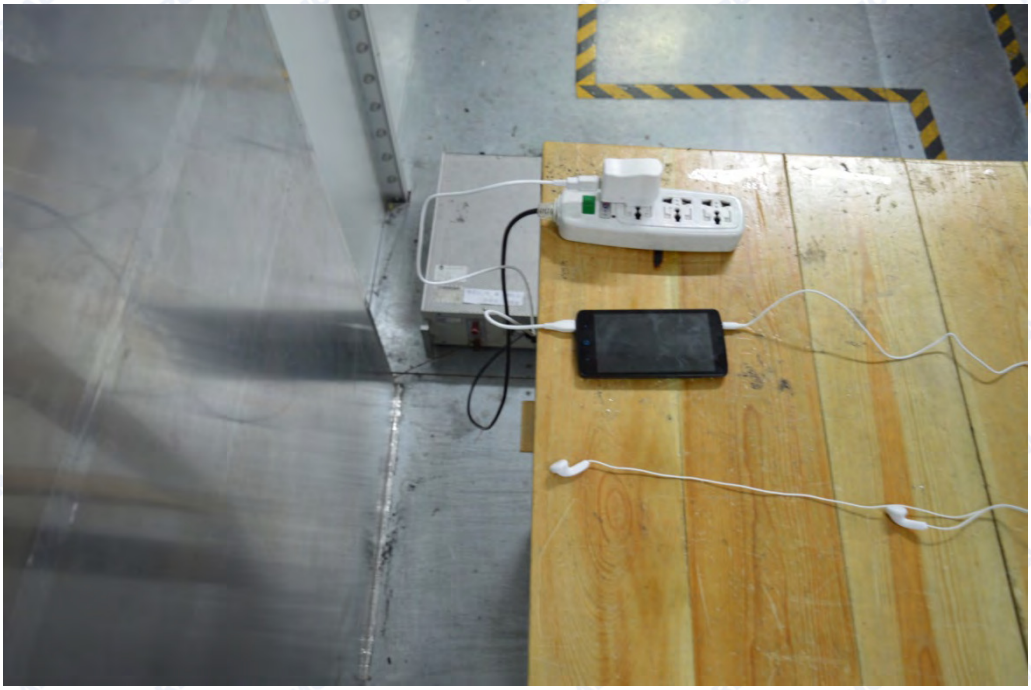
Annex A Test Setup Photos

1. Conducted emission main's port front view

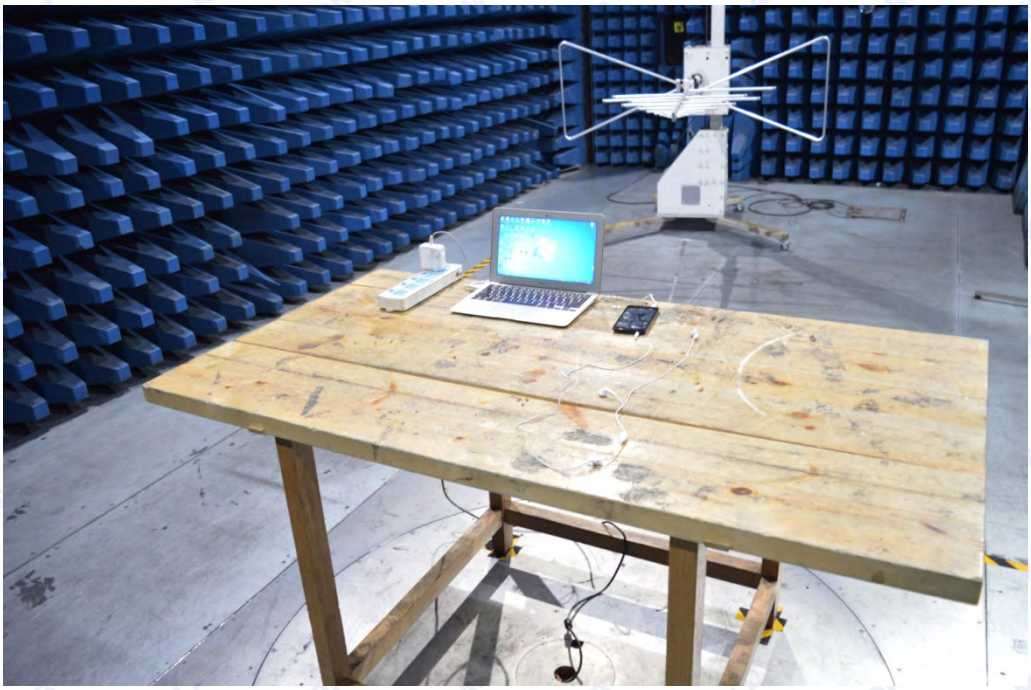


2. Conducted emission main's port side view

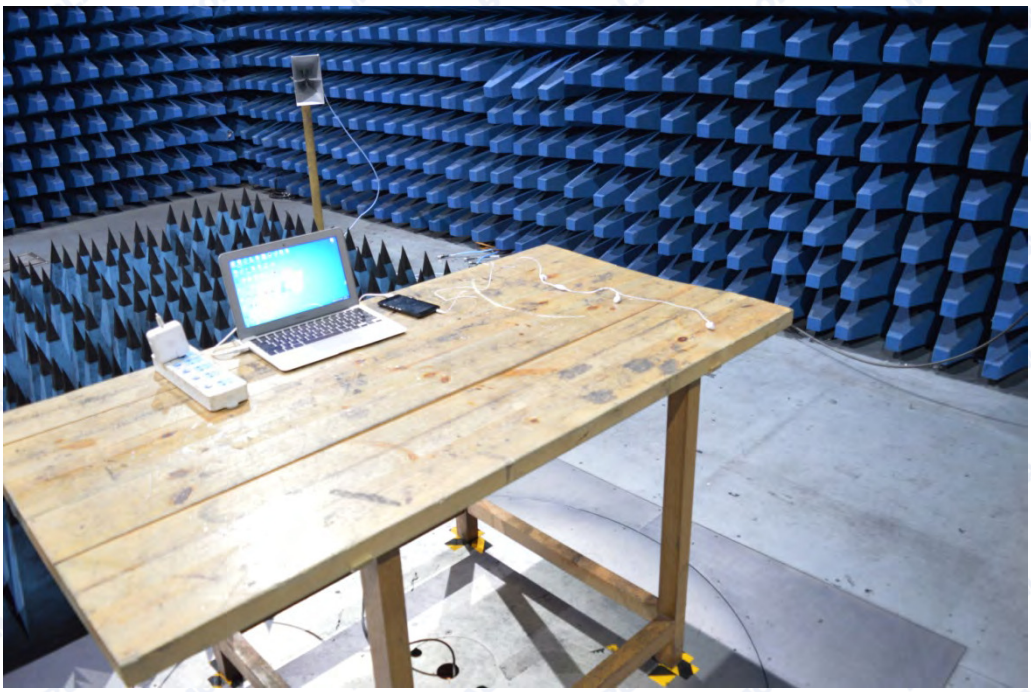




3. Radiated emission (30MHz-1GHz)



4. Radiated emission (above 1GHz)



Annex B Test Uncertainty

The uncertainty is calculated using the methods suggested in the "Guide to the Expression of Uncertainty in Measurement" (GUM) published by ISO.

Uncertainty of Conducted Emission:	±1.8dB
Uncertainty of Radiated Emission:	±3.1dB

Annex C Testing Laboratory Information

1. Identification of the Responsible Testing Laboratory

Company Name:	Shenzhen Morlab Communications Technology Co., Ltd.
Department:	Morlab Laboratory
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China
Responsible Test Lab Manager:	Mr. Su Feng
Telephone:	+86 755 36698555
Facsimile:	+86 755 36698525

2. Identification of the Responsible Testing Location

Name:	Shenzhen Morlab Communications Technology Co., Ltd. Morlab Laboratory
Address:	FL.3, Building A, FeiYang Science Park, No.8 LongChang Road, Block 67, BaoAn District, ShenZhen, GuangDong Province, P. R. China

3. Accreditation Certificate

Accredited Testing Laboratory: The FCC registration number is 695796.
(Shenzhen Morlab Communications Technology Co., Ltd.)

4. Test Environment Conditions

During the measurement, the environmental conditions were within the listed ranges:

Temperature (°C):	15 - 35
Relative Humidity (%):	30 - 60
Atmospheric Pressure (kPa):	86 - 106

***** END OF REPORT *****